IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re Application of: Davis, et al.

Serial No.: 10/628,001

Examiner: Stevenson, Andre C.

Confirmation No.: 3943

Title: METHOD FOR AUTOMATIC
DETERMINATION OF
SEMICONDUCTOR PLASMA
CHAMBER MATCHING AND
SOURCE OF FAULT BY
COMPREHENSIVE PLASMA
MONITORING

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SIR:

Case: AMAT/7938/ETCH/SILICON/JB

Filed: July 25, 2003

Group Art Unit: 2812

RESPONSE TO FINAL OFFICE ACTION DATED FEBRUARY 10, 2006

In response to the Final Office Action dated February 10, 2006, having a shortened statutory period for response set to expire on May 10, 2006, and the Advisory Action dated June 26, 2006, please enter this response and reconsider the claims pending in the application for reasons discussed below. The Applicants have submitted payment for a one-month extension to reply using the Patent Electronic Business Center. Although Applicants believe that no other fees are due in connection with this response, the Commissioner is hereby authorized to charge counsel's Deposit Account No. 20-0782 for any fees, including additional extension of time fees, required to make this response timely and acceptable to the Office.